Notice of References Cited	Application/Control No. 10/678,870	Applicant(s)/Patent Under Reexamination WAIN ET AL.	
	Examiner ISAAC T. TECKLU	Art Unit 2192	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,076,772	07-2006	Zatloukal, Kevin	717/147
*	B	US-7,107,578	09-2006	Alpern, David M.	717/124
*	C	US-5,774,728	06-1998	Breslau et al.	717/141
*	D	US-7,299,454 B2	11-2007	Pugh et al.	717/125
*	E	US-7,127,702	10-2006	Seki, Takeo	717/107
*	F	US-7,254,814 B1	08-2007	Cormier et al.	718/106
*	G	US-7,219,338 B2	05-2007	Venter, Barend H.	717/140
*	H	US-5,815,716 A	09-1998	Horiguchi, Tsuneo	717/157
*	I	US-6,799,718 B2	10-2004	Chan et al.	235/375
*	J	US-6,836,883 B1	12-2004	Abrams et al.	717/140
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.